Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	433	706/12	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/04/28 14:52
L2	408	1 and @ad<"20020222"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/04/28 14:56
L3	333	706/14	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/04/28 14:56
L4	315	3 and @ad<"20020222"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/04/28 15:00
L5	584	706/46	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/04/28 15:00
L6	536	5 and @ad<"20020222"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/04/28 15:06
L7	249	decision and tree and training and node and global and weighted and likelihood	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/04/28 15:06
L8	199	7 and @ad<"20020222"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2004/04/28 15:06

IEEE HOME | SEARCH IEEE | SHOT WEB ACCOUNT | CONTACT IEEE

Conferences



Publications/Services Standards

Welcome **United States Patent and Trademark Office**



Help FAQ Terms IEE	E Peer Review Quick Links Se.				
Welcome to IEEE Xplore® - Home - What Can I Access? - Log-out	Your search matched 0 of 1027552 documents. A maximum of 500 results are displayed, 50 to a page, sorted by Relevance Descending order. Refine This Search:				
Tables of Contents	You may refine your search by editing the current search expression or enterinew one in the text box.				
O- Journals & Magazines	decision and tree and training and likelihood and weigh				
O- Conference Proceedings	☐ Check to search within this result set				
O- Standards	Results Key: JNL = Journal or Magazine CNF = Conference STD = Standard				
Search					
O- By Author O- Basic O- Advanced	Results: No documents matched your query.				
Member Services					
O- Join IEEE O- Establish IEEE Web Account					
O- Access the IEEE Member Digital Library					
Home Log-out Journals C	Conference Proceedings Standards Search by Author Basic Search Advanced Search Join IEEE Web Account				

New this week | OPAC Linking Information | Your Feedback | Technical Support | Email Alerting | No Robots Please | Release Notes | IEEE Online | Publications | Help | FAQ | Terms | Back to Top

Copyright © 2004 IEEE — All rights reserved

ee





Membership Publications/Services Standards Conferences

Welcome



	RELEASE 1.6 United States Patent and Trademark Office				
Help FAQ Terms	IEEE Peer Review Quick Links Se				
Welcome to IEEE Xploi	· Ge				
O- Home O- What Can I Access?	Your search matched 2 of 1027552 documents. A maximum of 500 results are displayed, 50 to a page, sorted by Relevance Descending order.				
O- Log-out	Refine This Search:				
Tables of Contents	You may refine your search by editing the current search expression or enterinew one in the text box. decision and tree and training and confidence Check to search within this result set				
O- Journals & Magazines					
Conference Proceedings					
O- Standards	Results Key: JNL = Journal or Magazine CNF = Conference STD = Standard				
Search - By Author - Basic - Advanced Member Services - Join IEEE - Establish IEEE Web Account	1 Discriminative training for large vocabulary telephone-based name recognition McDermott, E.; Biem, A.; Tenpaku, S.; Katagiri, S.; Acoustics, Speech, and Signal Processing, 2000. ICASSP '00. Proceedings. 20 IEEE International Conference on , Volume: 6 , 5-9 June 2000 Pages:3739 - 3742 vol.6 [Abstract] [PDF Full-Text (396 KB)] IEEE CNF				
O- Access the IEEE Member Digital Library	2 Phone-context specific gender-dependent acoustic-models for continuous speech recognition Neti, C.; Roukos, S.; Automatic Speech Recognition and Understanding, 1997. Proceedings., 1997 Workshop on , 14-17 Dec. 1997 Pages:192 - 198 [Abstract] [PDF Full-Text (308 KB)] IEEE CNF				

Home | Log-out | Journals | Conference Proceedings | Standards | Search by Author | Basic Search | Advanced Search | Join IEEE | Web Account |
New this week | OPAC Linking Information | Your Feedback | Technical Support | Email Alerting | No Robots Please | Release Notes | IEEE Online
Publications | Help | FAQ | Terms | Back to Top

Copyright © 2004 IEEE — All rights reserved

h e eee g e ch e ch e eee

e c